# Week 1: Simulating quantum advantage with trapped ions

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### Introduction

We put all the functions for the coding tasks in the script assignment.jl.

### Task 1

In this task, we create a function getAmp2 to calculate the probability  $P(x) = |\langle x|\psi\rangle|^2$  of each bit-string x by taking a dot product between the the MPS  $(|\psi\rangle)$  and a simple product state  $|x\rangle$  (of bond dimension D=1). The state  $|\psi\rangle$  is obtained by applying the quantum circuit made of random one qubit and two qubit gates applied to the N qubits of the system we are simulating. These gates are applied in layers leading to an effective circuit of depth d. In Fig. 1, we plot 16 speckle patterns representing the state for a system of  $N \in \{2, 3, 4, 5\}$  qubits and random quantum circuits of depth  $d \in \{4, 16, 32, 64\}$ . Each speckle pattern consists of red circles with an area proportional to the probability. Owing to the random nature of the circuit one finds that the probabilities associated with different states are distributed randomly.

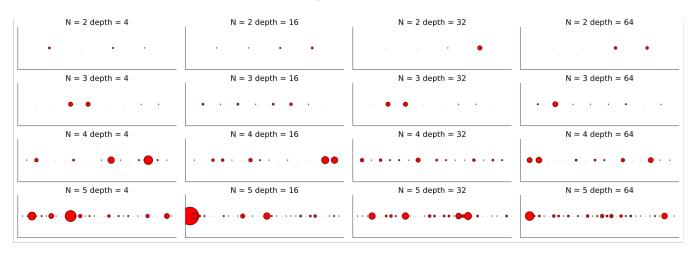


Figure 1: "Speckle patterns" displaying the probabilities of obtaining with N=2 to 5 and depths of 4, 16, 32, and 64.

We also make a function studyBondDim to calculate the bond dimension in the bonus problem by using the built-in function maxlinkdim in ITensor. In Fig. 2, we plot the bond dimensions as a function of circuit depth at several values of N. In all cases the function returns the bond dimension

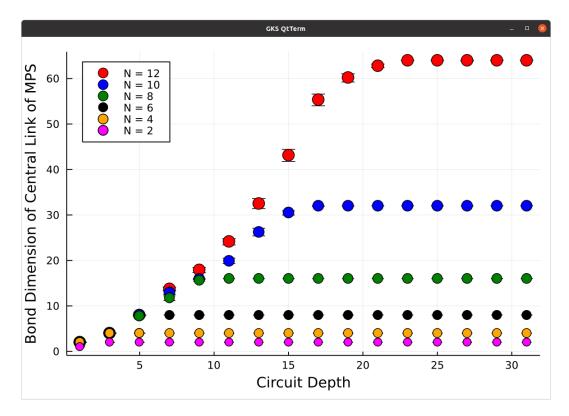


Figure 2: The bond dimensions of the central link associated with the MPS as a function of circuit depth for varying number of qubits.

associated with the central link of the MPS. It is straightforward to see that as the circuit depth is increase the entanglement in the system grows and ultimately saturates at the largest possible value  $2^{N/2}$ , i.e., D=2,4,8,16,32,64 for N=2,4,6,8,10,12. Note that as the circuits are random the scaling can be noisy. As such we perform an average over 20 random circuits to get a better understanding of the scaling.

### Task 2

To consider a single random bit flip, we modified the given run function by adding an argument wbitflip. If wbitflip is True, we assign a bit flip operator  $(\hat{\sigma}_z)$  at a random location (layer and qubit) of the circuit. In Fig. 3, we plot 16 different speckle patterns that result from the bit flip error.

### Task 3

In this task, we create a function cgfScalingSingle to calculate the cumulative distribution function (CDF) by numerically summing or integrating the probability distribution. Then we use the function cgfScaling to plot the CDF values with different depths and compare them with the theoretical value  $1 - e^{-2^N p}$ , as shown in Fig. 4

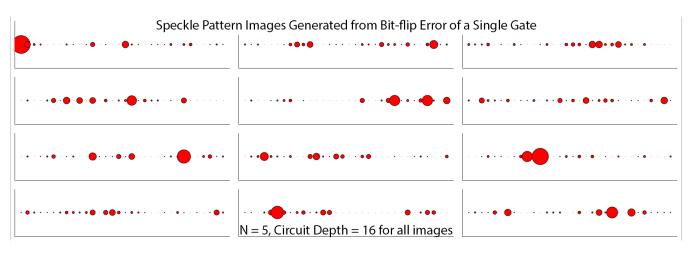


Figure 3: "Speckle patterns" displaying the probabilities of obtaining each of the 16 possible outcomes when sampling a 5-qubit circuit with a bit flip error occurred at a random location.

### Task 4

In the function crossEntropyValue, we calculate the linear cross-entropy benchmarking (XEB) fidelity  $\mathcal{F}_{XEB}$  between two states  $|\psi_0\rangle$  and  $|\psi_1\rangle$  as  $\mathcal{F}_{XEB} = 2^N \sum_x |\langle x|\psi_0\rangle|^2 |\langle x|\psi_1\rangle|^2 - 1$ . This is used as a helper function for computations of interest in this task.

In Fig. 5(a), the function crossEntropy computes  $\mathcal{F}_{XEB} = 2^N \sum_x |\langle x|\psi_0\rangle|^2 |\langle x|\psi_0(\Delta\Theta)\rangle|^2 - 1$ , i.e. the linear cross-entropy benchmarking (XEB) fidelity between the static state  $|\psi_0\rangle$  generated from a single random circuit and  $\psi_0(\Delta\Theta)\rangle$  generated by perturbing every 2-qubit gate of the static circuit by an angle  $\Delta\Theta$ . This results is for a system of N=8 qubits and circuit depth of d=512. The lack of averaging over random samples makes it difficult to understand the behaviour of the function leading to negative numbers in some cases (this is particularly true for small depths and system sizes). Consequently in in Figs. 5 (b) - (d), we calculate  $\mathcal{F}_{XEB}$  by averaging over a number of samples. This allows us to see a remarkable resurgence of  $\mathcal{F}_{XEB}$  at  $\Delta\Theta=\pi$ .

## **Business Application**

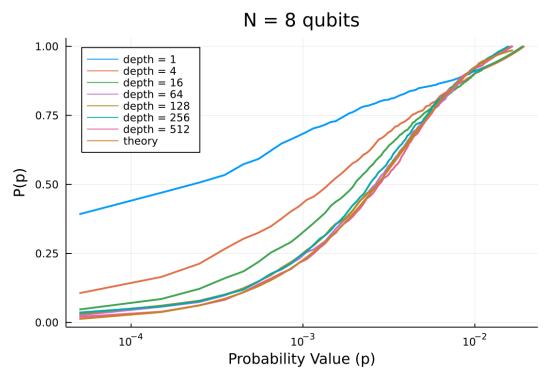


Figure 4: Calculated CDF as a function of the probability values p in log scale at different circuit depths in an 8-qubit circuit. When the depth is larger, the CDF converges toward the theoretical value  $1 - e^{-2^N p}$ .

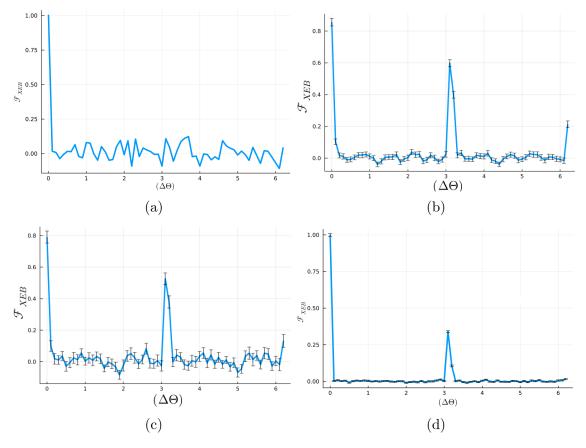


Figure 5: The crossed entropy benchmarking fidelity  $\mathcal{F}_{\text{XEB}}$  calculated as a function of the perturbation angle  $\Delta\Theta$  in a unit of radians at different numbers of qubit N, circuit depths d, and numbers of samples s. (a) N=8, d=512, without averaging; (b) N=4, d=128, s=200; (c) N=8, d=128, s=50; (d) N=10, d=128, s=50.